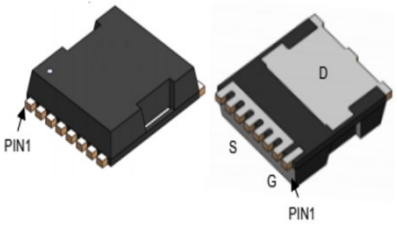
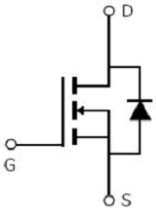
Main Product Characteristics:

V_{DSS}	100V
R_{DS}(on)	1.4mΩ (typ.)
I_D	351A



TOLL



Schematic Diagram

Features and Benefits:

- Advanced MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 150℃ operating temperature

Description:

It utilizes the latest processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications.

Absolute Max Rating:

Symbol	Parameter	Max.	Units
I_D @ T_C = 25°C	Continuous Drain Current, V_{GS} @ 10V ①	351	A
I_D @ T_C = 100°C	Continuous Drain Current, V_{GS} @ 10V ①	249	
I_{DM}	Pulsed Drain Current ②	1406	
P_D @T_C = 25°C	Power Dissipation ③	429	W
V_{DS}	Drain-Source Voltage	100	V
V_{GS}	Gate-to-Source Voltage	± 20	V
E_{AS}	Single Pulse Avalanche Energy @ L=0.5mH	1211	mJ
T_J T_{STG}	Operating Junction and Storage Temperature Range	-55 to +175	°C

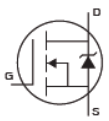
Thermal Resistance

Symbol	Characterizes	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-case ③	—	0.35	℃/W

Electrical Characteristics @T_A=25℃ unless otherwise specified

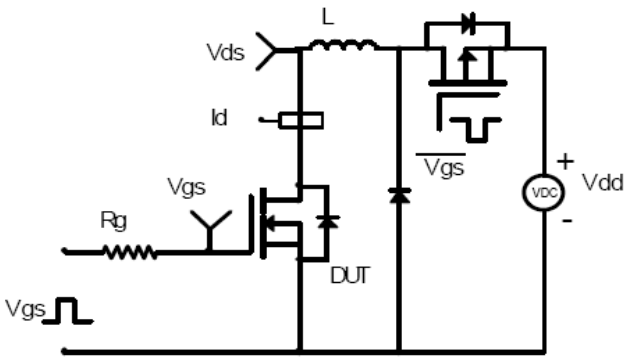
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source breakdown voltage	100	—	—	V	V_{GS} = 0V, I_D = 250μA
$R_{DS(on)}$	Static Drain-to-Source on-resistance	—	1.4	2	mΩ	V_{GS}=10V,I_D = 20A
$V_{GS(th)}$	Gate threshold voltage	2	—	4	V	V_{DS} = V_{GS}, I_D = 250μA
I_{DSS}	Drain-to-Source leakage current	—	—	1	μA	V_{DS} = 100V,V_{GS} = 0V
I_{GSS}	Gate-to-Source forward leakage	—	—	100	nA	V_{GS} =20V
		—	—	-100		V_{GS} = -20V
C_{iss}	Input capacitance	—	16400	—	pF	V_{GS} = 0V
C_{oss}	Output capacitance	—	2310	—		V_{DS} = 50V
C_{rss}	Reverse transfer capacitance	—	57	—		f = 1MHz
Q_g	Total gate charge	—	135	—	nC	I_D = 20A,
Q_{gs}	Gate-to-Source charge	—	35	—		V_{DS}=50V,
Q_{gd}	Gate-to-Drain("Miller") charge	—	27	—		V_{GS} = 10V
$t_{d(on)}$	Turn-on delay time	—	65	—	ns	V_{GS}=10V, V_{DD} =50V, R_{GEN}=3.6Ω,R_L=2.2Ω
t_r	Rise time	—	108	—		
$t_{d(off)}$	Turn-Off delay time	—	80	—		
t_f	Fall time	—	23	—		

Source-Drain Ratings and Characteristics

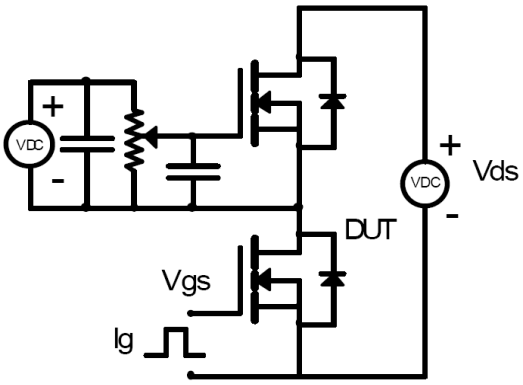
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	351	A	MOSFET symbol showing the integral reverse p-n junction diode. 
I_{SM}	Pulsed Source Current (Body Diode)	—	—	1406	A	
V_{SD}	Diode Forward Voltage	—	—	1.2	V	I_S=2A, V_{GS}=0V
t_{rr}	Reverse Recovery Time	—	85	—	ns	T_J = 25°C, I_F =20A, di/dt = 100A/μs
Q_{rr}	Reverse Recovery Charge	—	251	—	nC	

Test Circuits and Waveforms

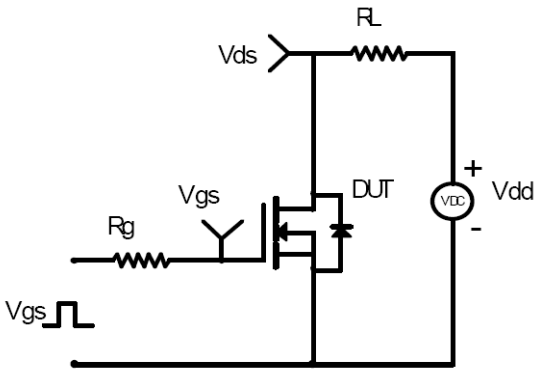
EAS Test Circuit:



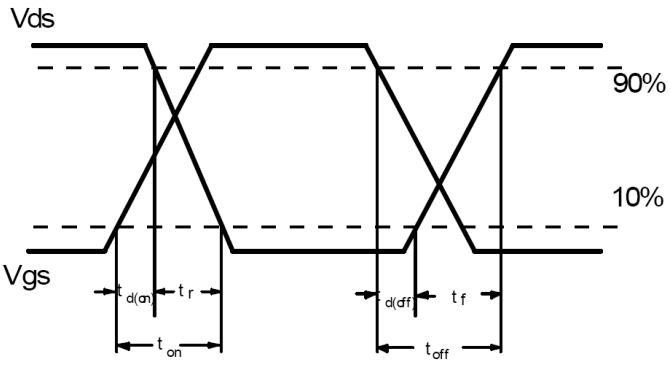
Gate Charge Test Circuit:



Switching Time Test Circuit:



Switching Waveforms:



Notes:

①Calculated continuous current based on maximum allowable junction temperature.

②Repetitive rating; pulse width limited by max. junction temperature.

③The power dissipation P_D is based on max. junction temperature, using junction-to-case thermal resistance.

Typical Electrical and Thermal Characteristics

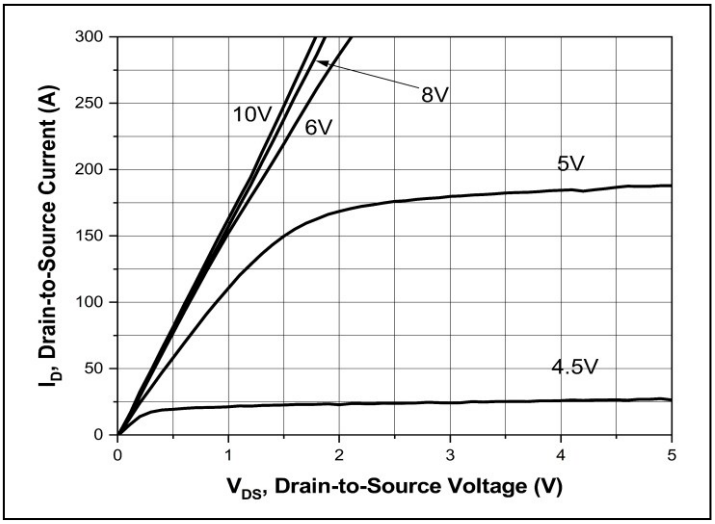


Figure1. Typical Output Characteristics

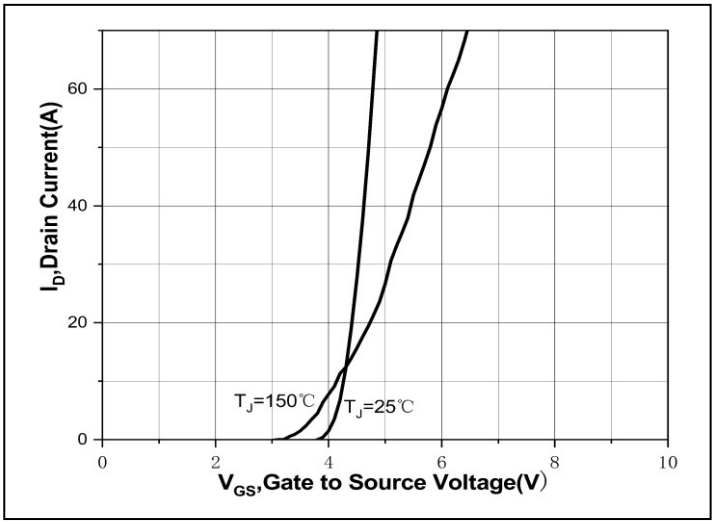


Figure2. Typical Transfer Characteristics

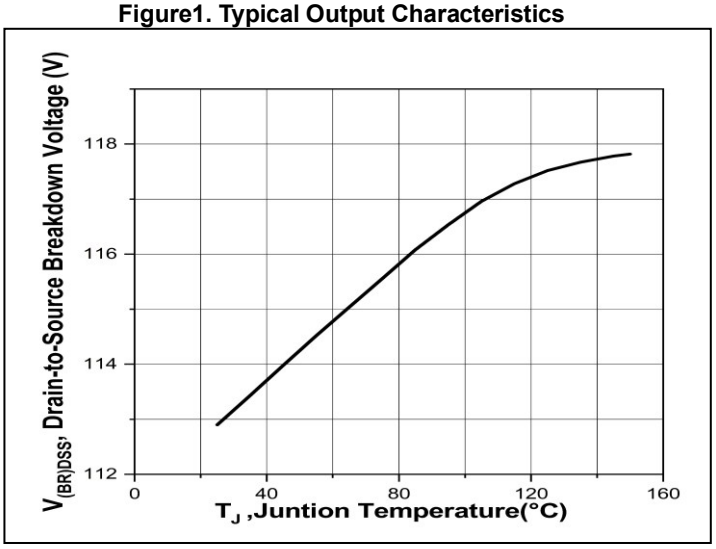


Figure3. Drain-to-Source Breakdown Voltage vs. Junction Temperature

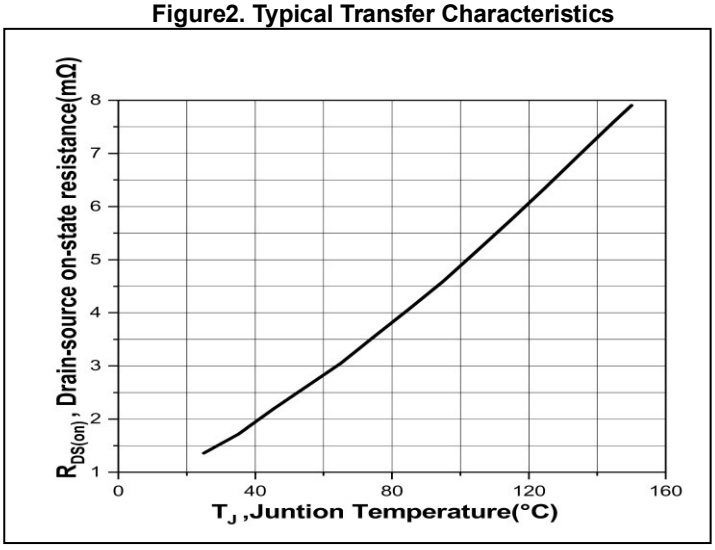


Figure4. Normalized On-Resistance vs. Junction Temperature

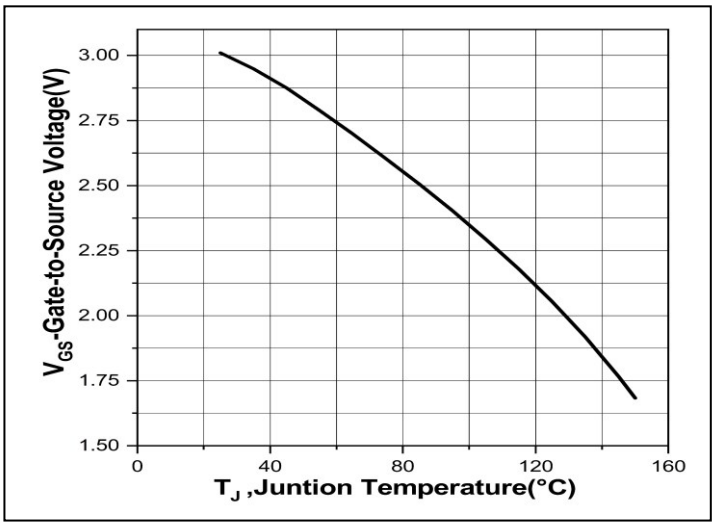


Figure5. Normalized V_{GS}(th) vs. Junction Temperature

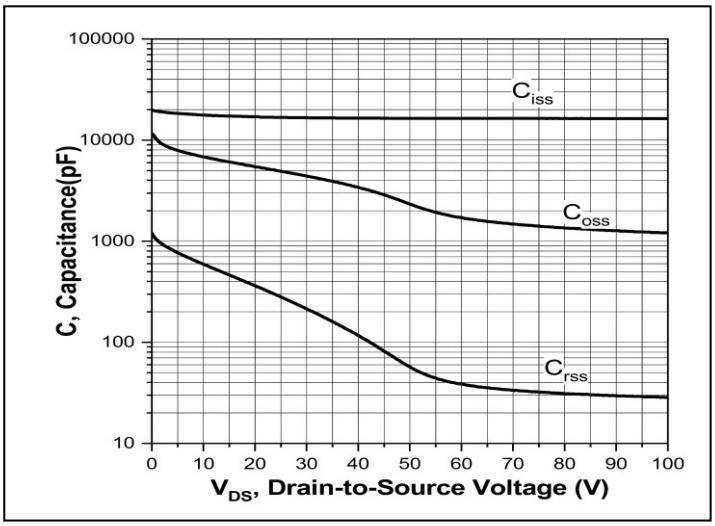


Figure6. Capacitance Characteristics

Typical Electrical and Thermal Characteristics

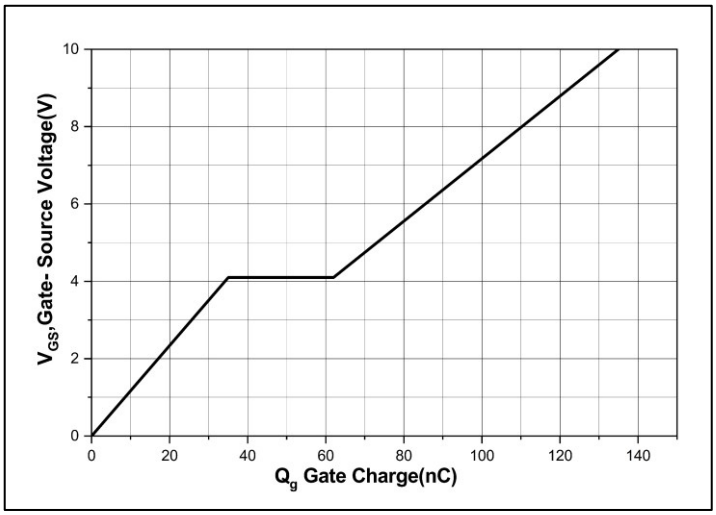


Figure7. Gate Charge

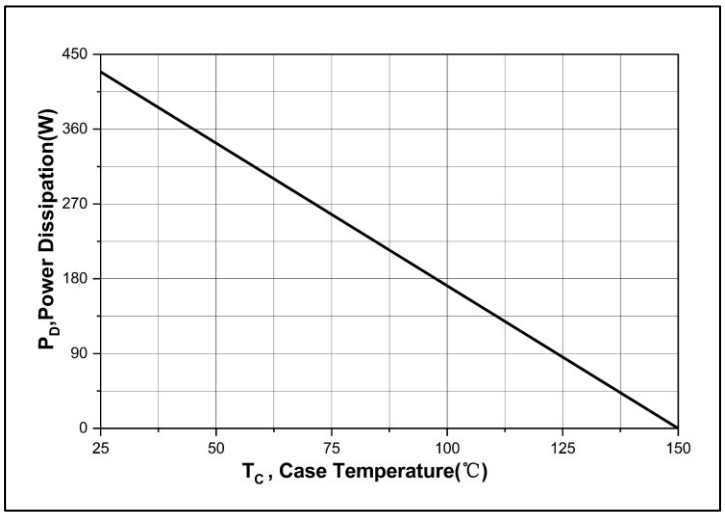
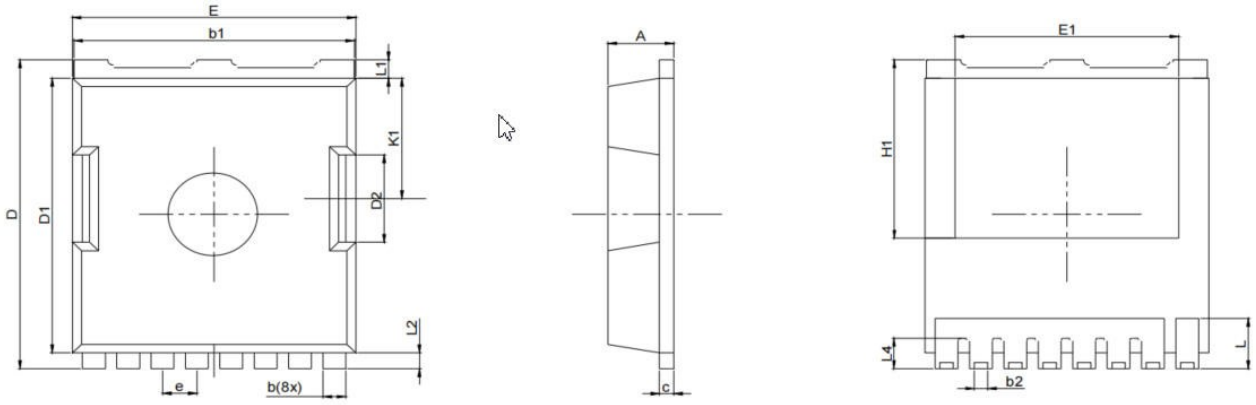


Figure8. Power Dissipation

Mechanical Data：

Unit:mm



Top View　　Side View　　Bottom View

DIM.	MILLIMETER		
	MIN.	NOM.	MAX.
A	2.20	2.30	2.40
b	0.70	0.80	0.90
b1	9.65	9.80	9.95
c	0.40	0.50	0.60
D	11.48	11.68	11.95
D1	10.28	--	10.70
D2		3.30	
E	9.70	9.90	10.10
E1		8.10	
e		1.20 (BSC)	
H1	6.70	7.00	7.30
K1		4.55	
L	1.35	--	2.10
L1		0.70	
L2		0.60	
L4	0.95	1.20	1.35

ATTENTION:

- Any and all Silikron products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life-support systems, aircraft's control systems, or other applications whose failure can be reasonably expected to result in serious physical and/or material damage. Consult with your Silikron representative nearest you before using any Silikron products described or contained herein in such applications.
- Silikron assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all Silikron products described or contained herein.
- Specifications of any and all Silikron products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer's products or equipment.
- Silikron Microelectronics (Suzhou) Co.,Ltd. strives to supply high-quality high-reliability products. However, any and all semiconductor products fail with some probability. It is possible that these probabilistic failures could give rise to accidents or events that could endanger human lives, that could give rise to smoke or fire, or that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits and error prevention circuits for safe design, redundant design, and structural design.
- In the event that any or all Silikron products(including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from the authorities concerned in accordance with the above law.
- No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written permission of Silikron Microelectronics (Suzhou) Co.,Ltd.
- Information (including circuit diagrams and circuit parameters) herein is for example only ; it is not guaranteed for volume production. Silikron believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements of intellectual property rights or other rights of third parties.
- Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc. When designing equipment, refer to the "Delivery Specification" for the Silikron product that you intend to use.